

The impact of GaN in BEV, providing a major step towards net-zero by 2050

Simon Stacey – COO 07/11/2024

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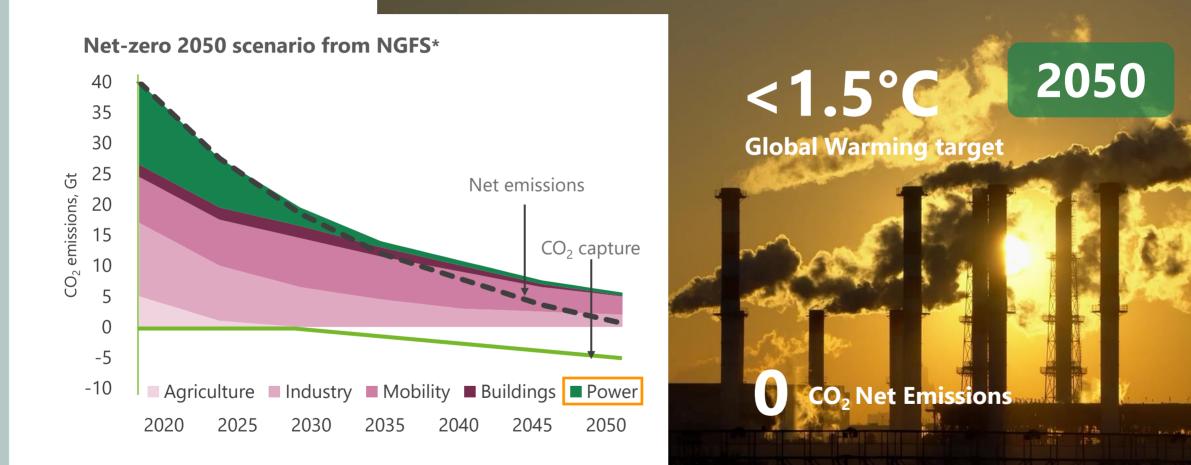
Cambridge GaN Devices at a Glance





The World Must Go for Net-zero Drastically Reduce Emissions Plus Removal

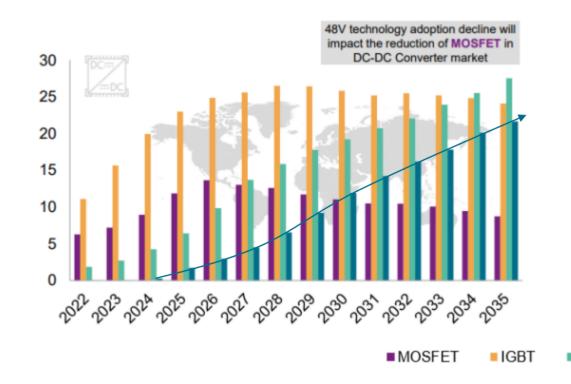




Sources: *Network for Greening the Financial System – CGD elaboration from McKinsey 2022 Net-zero transition report GaN will make an impact in Automotive, mainly in BEV OBC and DCDC will see GaN catching up on SiC and Si, growing at much faster rate

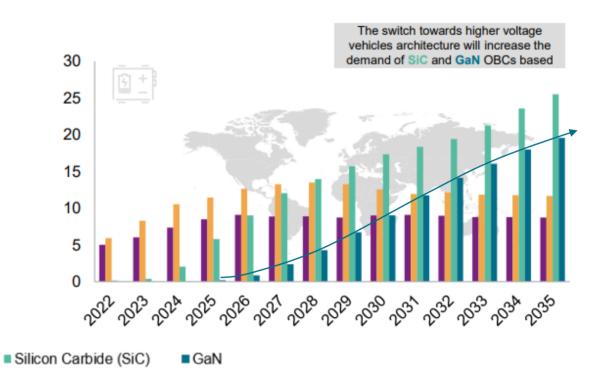
DC-DC Converter (million units)

Component volumes 2022 - 2035



On-board Charger (million units)

Component volumes 2022 - 2035



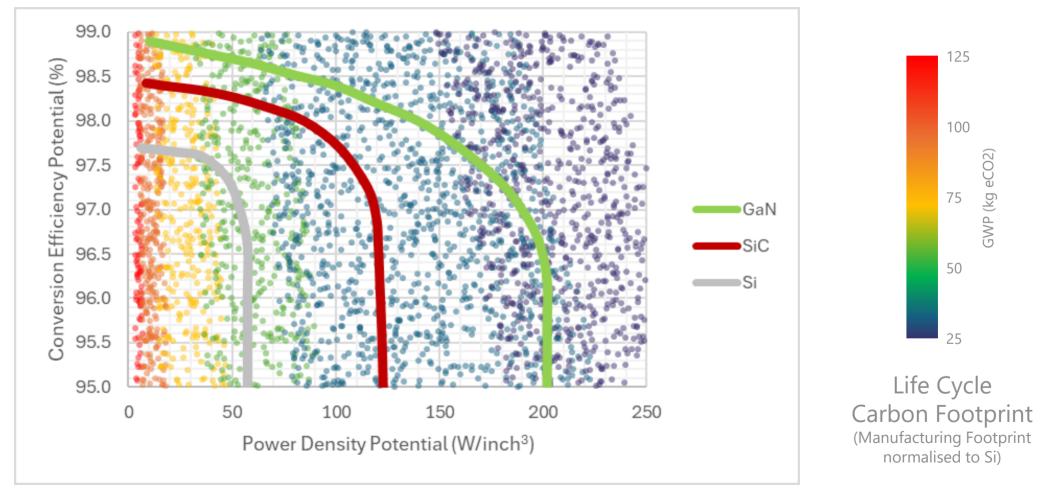
Source: SP Global, Automotive Power Electronics Roadmap, Oct 2023

CAMBRIDGE GaN DEVI

EVs to Deliver Low Environmental Impact

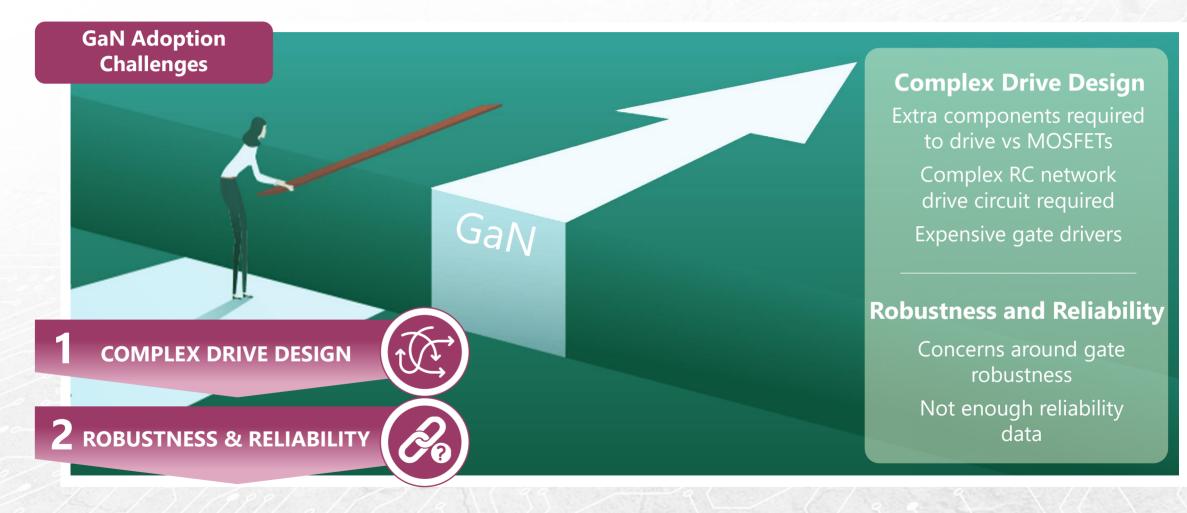


GaN Enables Highest Efficiencies, Highest Power Densities and Lowest Carbon Footprint



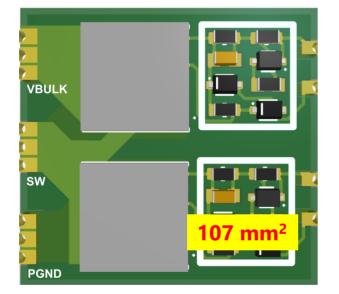
However... There are Barriers to GaN Adoption in High Power and Automotive Applications



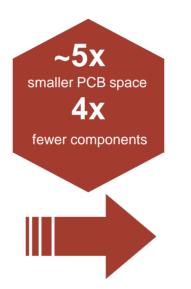


ICeGaN[®] Runs with Any MOSFET & IGBT Driver Smaller Driving Circuits, Bigger Copper Area, and Lower BoM Cost

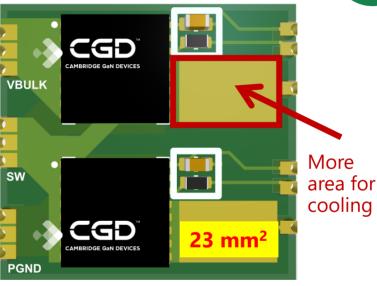




- Driving components: 16
- Area of driving circuits: 107 mm²



Half-bridge with ICeGaN



- Driving components: 4
- Area of driving circuits: 23 mm²

Larger cooling area \rightarrow lower operating temperature \rightarrow higher efficiency & reliability

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ICeGaN[®] Addresses the Challenge of Robustness



Extreme robustness with gate under dynamic voltage

R

Co

High threshold voltage for di/dt noise immunity

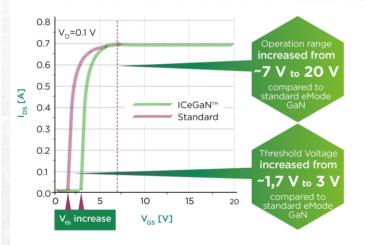
dv/dt Immunity No signs of shoot through

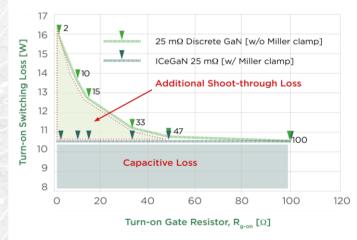
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Technology	25 °C	150 °C
ICeGaN	84 V	92 V
Si IGBT	80 V	80 V
SIC MOSFET	70 V	70 V
Std e-Mode GaN	24 V	25 V



B. Wang et al "Exceptional Gate Overvoltage Robustness in P-Gate GaN HEMT with Integrated Circuit Interface", APEC 2024





ICeGaN has been designed STARTING FROM RELIABILITY

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ICeGaN[®] for Traction Inverters – Top System Performance Subsciences

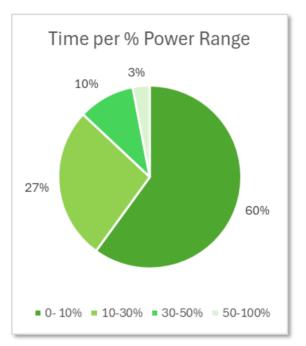


Si IGBT or SiC MOSFET

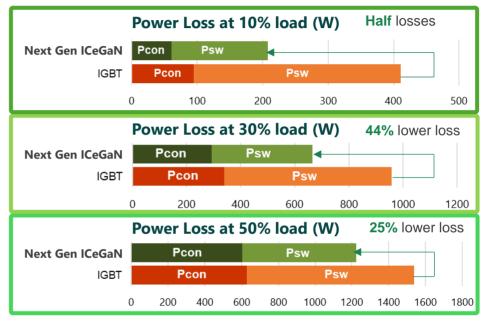


Main Inverter system analysis assumptions:

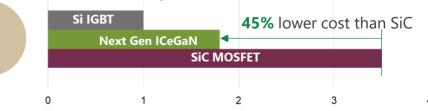
- 1. $V_{DC} = 400 \text{ V}$, SVPWM, Cos(phi) = 0.85, m = 0.8, F_{SW} = 10kHz
- 2. Next Gen ICeGaN spec: Vds = 650 V, Ids = 850A. ICeGaN: Ron, 125C = $10m\Omega$
- 3. Si IGBT for benchmark Infineon HyridPack Drive module FS820R08A6P2B
- 4. SiC: 650V/800A, Rdson = $3 \text{ m}\Omega$



Inverter Performance



Die cost estimation (normalized) for 400V/150kW power module



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Summary and Conclusions



- GaN HEMTs are the present and the future of Power Conversion, achieving Efficiencies, Power Densities and Sustainability Potential beyond other technologies
- Robust GaN solutions exploit the monolithic integration opportunities offered by lateral GaN technologies...as realised by CGD with ICeGaN[®]
- Implementation of Robust Chip Architectures make the Reliability of GaN the same, or better, than incumbent Si and SiC technologies
- Economies of Scale and System Level integration opportunities make ICeGaN[®] the technology of choice for all market segments

Dare to innovate differently



